

Search Notes



Application/Control No.

10/754,501

Examiner

Long Nguyen

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	333, 427, 68, 70, 72, 143, 198, 544	3/28/05	LN
316	68, 80, 81		
365	189.11		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East	3/28/05	LN